IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

ln re Ap	plication of:)	
KEISHI	SAITO, ET AL.)	
Applica	tion No.: Not Yet Assigned)	
Filed:	Concurrently Herewith)	
For:	SEMICONDUCTOR ELEMENT AND ITS MANUFACTURING METHOD) :)	July 23, 2003

This application is a divisional under 37 C.F.R. § 1.53(b) of U.S. Patent Appln. No. 09/839,891

Mail Stop Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed below and on the enclosed Form PTO-1449.

U.S. Patent No. 4,600,801 U.S. Patent No. 4,609,771 U.S. Patent No. 4,775,425 U.S. Patent No. 5,486,237 U.S. Patent No. 5,720,827 U.S. Patent No. 5,851,904 U.S. Patent No. 5,913,986 U.S. Patent No. 6,013,544 U.S. Patent No. 6,020,224 U.S. Patent No. 6,027,987 U.S. Patent No. 6,033,940 U.S. Patent No. 6,180,870

Europe 0 675 551 Germany 43 33 416 China 1175095A

- J. Meier, et al., "Towards High Efficiency Thin Film Silicon Solar Cells With The 'Micromorph' Concept", Solar Energy Materials and Solar Cells, vol. 49, pp. 35-44 (1997).
- J. Yi, et al., "Amorphous and Micro-Crystalline Silicon for Photovoltaic Application", Proc. of the Photovoltaic Spec. Conf., vol. 23, pp. 977-980 (1993).
- J. Meier, et al., "On The Way Towards High Efficiency Thin Film Silicon Solar Cells By The Micromorph Concept", Mat. Res. Soc. Symp. Proc., vol. 420, pgs. 3-14 (1996).
- A. Matsuda, "Structural Study on Amorphous-Microcrystalline Mixed-Phase Si:H Films", Jap. J. Appl. Phys., vol. 20, no. 6, pgs. L439-L442 (1981).
- A. Matsuda, et al., "Boron Doping of Hydrogenated Silicon Thin Films", Jap. J. Appl. Phys., vol. 20, no. 3, pgs. L183-L186 (1981).
- A. Matsuda, et al. "Electrical and Structural Properties of Phosphorous-Doped Glow-Discharge Si: F: H and Si:H Films", Jap. J. Appl. Phys., vol. 19, no. 6, pgs. L305-L308 (1980).
- S. Usui, et al., "Properties of Heavily Doped GD-Si With Low Resistivity", Journal of Non-Crystalline Solids, vol. 34, no. 1, pgs. 1-11 (1979).

All of the above documents were cited in parent Application No.

09/839,891 and/or grandparent Application No. 09/266,829 and might be deemed pertinent

for the reasons given there. The Examiner is respectfully directed to the Patent and

Trademark Office files for review of these documents. See MPEP § 609.

Inasmuch as the subject application is being filed concurrently herewith, it is believed that this Information Disclosure Statement is timely. See 37 C.F.R. 1.97(b)(3). Accordingly, the Examiner is urged to study this information in its entirety and to form an independent determination of the materiality of the information to the claimed invention. Additionally, the Examiner is requested to indicate that this information has been

considered by initialing the appropriate portion of the Form PTO-1449.

Applicants' undersigned attorney may be reached in our Costa Mesa, California office by telephone at (714) 540-8700. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Attorney for Applicants

Registration No. 52.310

FITZPATRICK, CELLA, HARPER & SCINTO

30 Rockefeller Plaza

New York, New York 10112-3801

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FORM PTO 1449 (modified)				ATTY DOCKET NO. 03500.013395.2	APPLICATION NO. Div. of 09/839,891				
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				APPLICANT KEISHI SAITO ET AL.					
			FILING DATE H rewith		GROUP NYA				
				J.S. PATENT DOCUMENTS					
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
	4,600,801	7/15/86		Guha et al.	136	249			
	4,609,771	9/2/86		Guha et al.	136	249	 		
	4,775,425	10/4/88		Guha et al.	136	249			
	5,486,237	1/23/96		Sano et al.	136	258			
	5,720,827	2/24/98		Simmons	136	250			
	5,851,904	12/22/98		Schwarz et al.	438	482			
	5,913,986	6/22/99		Matsuyama	136	255			
	6,013,544	1/11/00		Makita et al.	438	166			
L	FOREIGN PATENT DOCUMENTS								
	DOCUMENT NUMBER	DATE		COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
	0 675 551	10/4/95		Europe					
	43 33 416	4/6/95		Germany					
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
J. Meier, et al., "Towards High Efficiency Thin Film Silicon Solar Cells With The 'Micromorph' Concept", Solar Energy Materials and Solar Cells, vol. 49, pp. 35-44 (1997).									
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	S. Usui, et al., "Properties of Heavily Doped GD-Si With Low Resistivity", Journal of Non-Crystalline Solids, vol. 34, no. 1, pgs. 1-11 (1979).								

DATE CONSIDERED

EXAMINER

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

• FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.013395.2	APPLICATION NO. Div. of 09/839,891			
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			FILING DATE Herewith		GROUP		
			U.S. PATENT DOCUMENTS				
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	6,020,224	2/1/00	Shimogaichi et al.	438	158		
	6,027,987	2/22/00	Yamazaki et al.	438	486		
	6,033,940	3/7/00	Jinda	438	151		
	6,180,870	1/30/01	Sano et al.	136	258		
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
	1175095A	3/4/98	China				
	<u> </u>	HER DOCUMENT(S)	(Including Author, Title, Date, Pertine	nt Pages, Etc.)			
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